


<b>Search Notes</b>  	<b>Application/Control No.</b>  10566719	<b>Applicant(s)/Patent Under Reexamination</b>  OHBAYASHI ET AL.
	<b>Examiner</b>  Arnberg, Megan	<b>Art Unit</b>  1796

### SEARCHED

Class	Subclass	Date	Examiner
523	445	Dec. 6, 2007	MCA
523	445	June 12, 2008	MCA

### SEARCH NOTES

Search Notes	Date	Examiner
Inventor name search -see search history printout	Dec. 6, 2007	MCA
EAST (US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT) - see search history printout	Dec. 6, 2007	MCA
Updated Inventor name search -see search history	June 12, 2008	MCA
Updated EAST search -see search history	June 12, 2008	MCA

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner